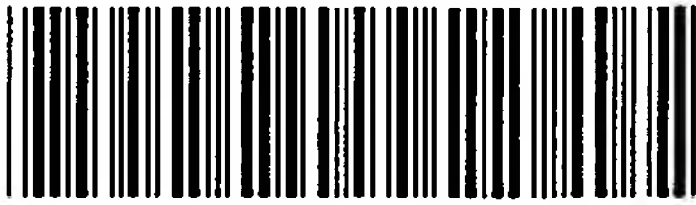


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/058,036	TAKAGI ET AL.	
	Examiner	Art Unit	
	Chris Parry	2623	

SEARCHED			
Class	Subclass	Date	Examiner
725	38	4/5/2006	CLP
725	56-57	4/6/2006	CLP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
See attached search history from EAST (USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; IMB_TDB).	4/13/2006	CLP
Consulted Primaries Victor Kostak and Brian Yenke on areas of search in class 348.	4/7/2006	CLP
348/569,570 - (text search only - see search history).	4/10/2006	CLP
348/731-734 - (text search only - see search history).	4/7/2006	CLP
Consulted Scott Beliveau, Jason Salce, Andrew Koenig on areas of search in class 725.	4/12/2006	CLP
Consulted Hai Tran and Reuben Brown on areas of search in class 725.	4/12/2006	CLP
Consulted SPE Chris Grant on areas of search in class 725.	4/12/2006	CLP
Conducted a double patenting search.	4/12/2006	CLP